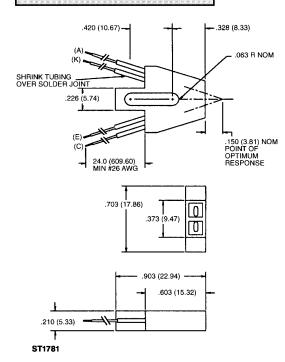


REFLECTIVE OBJECT SENSOR

QRC1133

PACKAGE DIMENSIONS



FUNCTION WIRE COLOR

(C) COLLECTOR WHITE (E) EMITTER (K) CATHODE (A) ANODE BLUE GREEN ORANGE

NOTES:

- 1. DIMENSIONS ARE IN INCHES (mm).
 2. TOLERANCE IS ± .010 (.25)
 UNLESS OTHERWISE SPECIFIED.

DESCRIPTION

The QRC1133 consists of an infrared emitting diode and an NPN silicon phototransistor mounted side by side on a converging optical axis in a black plastic housing. The phototransistor reponds to radiation from the emitting diode only when a reflective object passes within its field of view. The area of optimum response approximates a circle .200" in diameter.

FEATURES

- Phototransistor output
- High Sensitivity
- Low cost plastic housing
- #26 AWG, 24 inch PVC wire termination



REFLECTIVE OBJECT SENSOR

Storage Temperature	
Soldering:	-40 0 10 +63 (
Lead Temperature (Iron)	240°C for 5 sec. (2.3.
Lead Temperature (Flow)	260°C for 10 sec. (2.
INPUT DIODE	
	50 m/
	5.0 Volt
Power Dissipation	100 mW
DUTPUT TRANSISTOR	
	30 \
Emitter-Collector Voltage	5 N
Collector Current	

ELECTRICAL CHARACTERISTICS (T _A = 25°C)								
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNITS	TEST CONDITIONS		
INPUT DIODE								
Forward Voltage	$V_{\scriptscriptstyle F}$	_		1.70	٧	$I_F = 40 \text{ mA}$		
Reverse Leakage Current	I _A			100	μΑ	V _R = 2.0 V		
OUTPUT TRANSISTOR						-		
Emitter-Collector Breakdown	BV_{CEO}	5		_	V	$I_E = 100 \mu A$		
Collector-Emitter Breakdown	BV _{CEO}	30		_	٧	I _c = 1.0 mA		
Collector-Emitter Leakage	I _{CEO}	_		100	nA	V _{CE} = 10.0 V		
COUPLED		· ·						
On-State Collector Current	I _{C(ON)}	0.20		_	mA	$I_F = 40 \text{ mA}, V_{CE} = 5 \text{ V}, D = .150''^{(5.7)}$		
Crosstalk	I _{cx}			1.00	μΑ	$I_F = 40 \text{ mA}, V_{CE} = 5 V^{(6)}$		
Saturation Voltage	V _{CE(SAT)}			0.40	V	$I_F = 40 \text{ mA}, I_C = 0.1 \text{ mA}, D = .150"$		

NOTES

- Derate power dissipation linearly 1.67 mW/°C above 25°C.
 RMA flux is recommended.

- Methanol or Isopropyl alcohols are recommended as cleaning agents.
 Soldering iron tip 1/6" (1.6 mm) from housing.
 D is the distance from the assembly face to the reflective surface.
 Cross talk is the photocurrent measured with current to the input diode and no reflecting surface.
 Measured using Eastman Kodak neutral test card with 90% diffused reflecting surface.